Searcn Notes			

Applicatio	n No.	Applicant(s)	
10/660,73	1	HAN, IN HEE	
Examiner		Art Unit	
Jipina Lu		3749	

SEARCHED			
Class	Subclass	Date	Examiner
34	218	12/26/2004	J.L.
	232		
	233		
	596		
	63		
	604		
	260		
ABOVE	UPDATED	7/22/2005	JL
ABOVE	UPDATED	2/21/2006	JL

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
<u> </u>				

(INCLUDING SEARC	HSTRATEGY	<u>') </u>
	DATE	EXMR
	-	
		
		r
		
		<u> </u>